TEST LOG



Article number: 112	028WS001	Sprac	he Language ODE	⊙en Ofr	ONL OES OPL
Internal number:		Serial number:		Date:	13.12.2023
Device status:			Bemerkungen / Remarks:		
As good as new unused					
Damaged (light) technica	ally inspected				
Damaged (dents/scratches	5) technically checked	1			
Signs of wear (light) tech	inically checked				
Traces of use technically	checked				
Product Specific Information	on				
VDE test conducted:	YES	NO	NO ⁻	T NECESSARY	
Device complete:	YES	NO			
All functions tested:	YES	NO			
Device cleaned:	YES	NO			
Packaging:					
Original packaging					
Original packaging (dama	ged)				

Substitute packaging

Picture 1



TEST LOG | A-LAGER



Picture 2



Picture 3



TEST LOG | A-LAGER





Picture 5







